

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/781,693	CHANG, TAI-JAY
Examiner	Art Unit	
Michael Pak	1646	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	69.1, 326.1 <del>500</del> 325	3/18/05	WWD
536	23.5	1	1
STL SEQ SEARCH		11-22-04	WWD